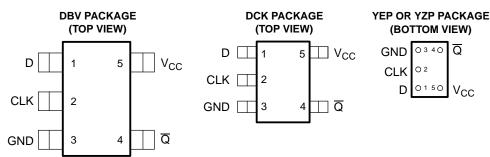
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FEATURES

- Available in the Texas Instruments
 NanoStar[™] and NanoFree[™] Packages
- Low Static-Power Consumption (I_{CC} = 0.9 μA Max)
- Low Dynamic-Power Consumption (C_{pd} = 4.3 pF Typ at 3.3 V)
- Low Input Capacitance (C_i = 1.5 pF Typ)
- Low Noise Overshoot and Undershoot <10% of V_{CC}
- I_{off} Supports Partial-Power-Down Mode Operation
- Schmitt-Trigger Action Allows Slow Input Transition and Better Switching Noise Immunity at the Input (V_{hvs} = 250 mV Typ at 3.3 V)

- Wide Operating V_{CC} Range of 0.8 V to 3.6 V
- Optimized for 3.3-V Operation
- 3.6-V I/O Tolerant to Support Mixed-Mode Signal Operation
- t_{pd} = 4.3 ns Max at 3.3 V
- Suitable for Point-to-Point Applications
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Performance Tested Per JESD 22
 - 2000-V Human-Body Model (A114-B, Class II)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)
- ESD Protection Exceeds ±5000 V With Human-Body Model



See mechanical drawings for dimensions.

DESCRIPTION/ORDERING INFORMATION

The AUP family is TI's premier solution to the industry's low-power needs in battery-powered portable applications. This family ensures a very low static- and dynamic-power consumption across the entire V_{CC} range of 0.8 V to 3.6 V, resulting in increased battery life (see Figure 1). This product also maintains excellent signal integrity (see Figure 2).

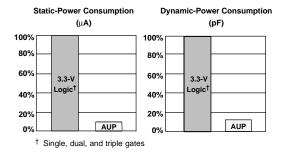


Figure 1. AUP - The Lowest-Power Family

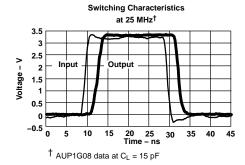


Figure 2. Excellent Signal Integrity

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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DESCRIPTION/ORDERING INFORMATION (CONTINUED)

This is a single positive-edge-triggered D-type flip-flop. When data at the data (D) input meets the setup time requirement, the data is transferred to the Q output on the positive-going edge of the clock pulse. Clock triggering occurs at a voltage level and is not directly related to the rise time of the clock pulse. Following the hold-time interval, data at the D input can be changed without affecting the levels at the outputs.

NanoStar[™] and NanoFree[™] package technology is a major breakthrough in IC packaging concepts, using the die as the package.

This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

ORDERING INFORMATION

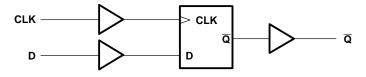
T _A	PACKAGE ⁽¹⁾		ORDERABLE PART NUMBER	TOP-SIDE MARKING (2)
	NanoStar™ – WCSP (DSBGA) 0.23-mm Large Bump – YEP	- Reel of 3000	SN74AUP1G80YEPR	ШV
	NanoFree™ – WCSP (DSBGA) 0.23-mm Large Bump – YZP (Pb-free)		SN74AUP1G80YZPR	HX_
–40°C to 85°C	SOT (SOT-23) – DBV	Reel of 3000	SN74AUP1G80DBVR	H80
		Reel of 250	SN74AUP1G80DBVT	По0_
	SOT (SC-70) – DCK	Reel of 3000	SN74AUP1G80DCKR	HX
	00 (00-10)	Reel of 250	SN74AUP1G80DCKT	11X_

⁽¹⁾ Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE

INPU	TS	OUTPUT
CLK	D	Q
1	Н	L
1	L	Н
L or H	X	ℚ 0

LOGIC DIAGRAM (POSITIVE LOGIC)



⁽²⁾ DBV/DCK: The actual top-side marking has one additional character that designates the assembly/test site. YEP/YZP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following character to designate the assembly/test site. Pin 1 identifier indicates solder-bump composition (1 = SnPb, · = Pb-free).



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Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CC}	Supply voltage range		-0.5	4.6	V
VI	Input voltage range ⁽²⁾		-0.5	4.6	V
Vo	Voltage range applied to any output in the high-	-impedance or power-off state ⁽²⁾	-0.5	4.6	V
Vo	Voltage range applied to any output in the high	tage range applied to any output in the high or low state $^{(2)}$ ut clamp current $V_1 < 0$			
I _{IK}	Input clamp current	V _I < 0		-50	mA
I _{OK}	Output clamp current	V _O < 0		-50	mA
Io	Continuous output current			±20	mA
	Continuous current through V _{CC} or GND			±50	mA
		DBV package		206	
θ_{JA}	Package thermal impedance (3)	DCK package		252	°C/W
		YEP/YZP package		132	
T _{stg}	Storage temperature range		-65	150	°C

⁽¹⁾ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

Recommended Operating Conditions(1)

			MIN	MAX	UNIT
V _{CC}	Supply voltage		0.8	3.6	V
		$V_{CC} = 0.8 \text{ V}$	V _{CC}		
V	High-level input voltage	$V_{CC} = 1.1 \text{ V to } 1.95 \text{ V}$	$0.65 \times V_{CC}$		V
V_{IH}	nigh-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.6		V
		V_{CC} = 3 V to 3.6 V	2		
		$V_{CC} = 0.8 \text{ V}$		0	
V	Low-level input voltage	$V_{CC} = 1.1 \text{ V to } 1.95 \text{ V}$		$0.35 \times V_{CC}$	V
V_{IL}	Low-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7	V
		$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$		0.9	
V_{I}	Input voltage		0	3.6	V
Vo	Output voltage		0	V _{CC}	V
		V _{CC} = 0.8 V		-20	μΑ
	High-level output current ⁽²⁾	V _{CC} = 1.1 V		-1.1	
		V _{CC} = 1.4 V		-1.7	
I _{OH}		V _{CC} = 1.65		-1.9	mA
		$V_{CC} = 2.3 \text{ V}$		-3.1	
		V _{CC} = 3 V		-4	
		V _{CC} = 0.8 V		20	μΑ
		V _{CC} = 1.1 V		1.1	
	Low-level output current ⁽²⁾	V _{CC} = 1.4 V		1.7	
l _{OL}	Low-level output current.	V _{CC} = 1.65 V		1.9	
		$V_{CC} = 2.3 \text{ V}$	3.1		
		V _{CC} = 3 V		4	
Δt/Δν	Input transition rise or fall rate	V _{CC} = 0.8 V to 3.6 V		200	ns/V
T _A	Operating free-air temperature	·	-40	85	°C

All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

⁽²⁾ The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

⁽³⁾ The package thermal impedance is calculated in accordance with JESD 51-7.

⁽²⁾ Defined by the signal integrity requirements and design-goal priorities.



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Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{cc}	Т,	_A = 25°C	T _A = -40°C to 85°C	UNIT
			MIN	TYP MAX	MIN MAX	
	I _{OH} = -20 μA	0.8 V to 3.6 V	V _{CC} - 0.1		V _{CC} - 0.1	
	I _{OH} = -1.1 mA	1.1 V	$0.75 \times V_{CC}$		$0.7 \times V_{CC}$	
	$I_{OH} = -1.7 \text{ mA}$	1.4 V	1.11		1.03	
V	$I_{OH} = -1.9 \text{ mA}$	1.65 V	1.32		1.3	V
V _{OH}	$I_{OH} = -2.3 \text{ mA}$	2.3 V	2.05		1.97	V
	I _{OH} = -3.1 mA	2.3 V	1.9		1.85	
	$I_{OH} = -2.7 \text{ mA}$	3 V	2.72		2.67	
	$I_{OH} = -4 \text{ mA}$	3 V	2.6		2.55	
	I _{OL} = 20 μA	0.8 V to 3.6 V		0.1	0.1	
	I _{OL} = 1.1 mA	1.1 V		$0.3 \times V_{CC}$	$0.3 \times V_{CC}$	
	I _{OL} = 1.7 mA	1.4 V		0.31	0.37	
V	I _{OL} = 1.9 mA	1.65 V		0.31	0.35	V
V _{OL}	I _{OL} = 2.3 mA	2.3 V		0.31	0.33	
	I _{OL} = 3.1 mA	2.3 V		0.44	0.45	
	I _{OL} = 2.7 mA	3 V		0.31	0.33	
	I _{OL} = 4 mA	3 V		0.44	0.45	
I _I D or CLK input	V _I = GND to 3.6 V	0 V to 3.6 V		0.1	0.5	μΑ
I _{off}	V_I or $V_O = 0$ V to 3.6 V	0 V		0.2	0.6	μΑ
$\Delta I_{ m off}$	V_I or $V_O = 0$ V to 3.6 V	0 V to 0.2 V		0.2	0.6	μΑ
I _{CC}	$V_I = GND \text{ or } V_{CC} \text{ to } 3.6 \text{ V}, I_O = 0$	0.8 V to 3.6 V		0.5	0.9	μΑ
ΔI_{CC}	$V_I = V_{CC} - 0.6 \text{ V},^{(1)} I_O = 0$	3.3 V		40	50	μΑ
C	V – V or CND	0 V		1.5		nΕ
C _i	$V_I = V_{CC}$ or GND	3.6 V		1.5		pF
Co	V _O = GND	0 V		3		pF

⁽¹⁾ One input at V_{CC} – 0.6 V, other input at V_{CC} or GND



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Timing Requirements

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

			V _{cc}	T _A = 25°C	$T_A = 25^{\circ}C$ $T_A = -40^{\circ}C$ to $85^{\circ}C$		UNIT
				TYP	MIN	MAX	
			0.8 V			20	
			1.2 V ± 0.1 V			80	
,			1.5 V ± 0.1 V			120	MHz
f _{clock}	Clock frequency		1.8 V ± 0.15 V			160	MHZ
			2.5 V ± 0.2 V			220	
			3.3 V ± 0.3 V			260	
			0.8 V		5.5		
			1.2 V ± 0.1 V		2.5		
	Dulas duration CLK high and		1.5 V ± 0.1 V		1.5		
t _w	Pulse duration, CLK high or lo	DW .	1.8 V ± 0.15 V		1.6		
			2.5 V ± 0.2 V		1.7		
			3.3 V ± 0.3 V		1.9		
			0.8 V	3.4	6.7		
			1.2 V ± 0.1 V		2.4		ns
		Data biah	1.5 V ± 0.1 V		1.2		
		Data high	1.8 V ± 0.15 V		0.8		
			2.5 V ± 0.2 V		0.6		
	Setup time before CLK↑		3.3 V ± 0.3 V		0.4		
t _{su}	Setup time before CLK		0.8 V	3.4	8.9		
			1.2 V ± 0.1 V		2		
		Data low	1.5 V ± 0.1 V		1.3		
		Data low	1.8 V ± 0.15 V		1.1		ns
			2.5 V ± 0.2 V		0.8		
			3.3 V ± 0.3 V		0.7		
			0.8 V	0	1		
			1.2 V ± 0.1 V		0		
	Hold time data after CLIVA		1.5 V ± 0.1 V		0		no
t _h	Hold time, data after CLK↑		1.8 V ± 0.15 V		0		ns
			2.5 V ± 0.2 V		0		
1			3.3 V ± 0.3 V		0		



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Switching Characteristics

over recommended operating free-air temperature range, $C_L = 5 \text{ pF}$ (unless otherwise noted) (see Figure 3 and Figure 4)

PARAMETER	FROM (INPUT)		V _{cc}	T _A = 25°C			T _A = -40°C to 85°C		UNIT
				MIN	TYP	MAX	MIN	MAX	
			0.8 V		91		90		
			1.2 V ± 0.1 V		175		220		
f			1.5 V ± 0.1 V		237		230		MHz
f _{max}			1.8 V \pm 0.15 V		269		240		IVII IZ
			2.5 V \pm 0.2 V		280		250		
			3.3 V \pm 0.3 V		280		260		
			0.8 V		17.2				
			1.2 V ± 0.1 V	3.2	7.1	14.9	2.7	16.3	
	CLK	Q	1.5 V ± 0.1 V	1.9	5	9.8	2.1	10.3	
t _{pd}	OLK	Q	1.8 V ± 0.15 V	1.7	3.9	7.6	1.6	8.1	ns
			2.5 V ± 0.2 V	1.4	2.8	5.3	1.2	5.6	
			3.3 V ± 0.3 V	1.2	2.2	4.1	1	4.4	

Switching Characteristics

over recommended operating free-air temperature range, $C_L = 10 \text{ pF}$ (unless otherwise noted) (see Figure 3 and Figure 4)

PARAMETER	FROM	TO (OUTPUT)	V _{CC}	T _A = 25°C			T _A = -40°C to 85°C		UNIT
	(INPUT)	(001701)		MIN	TYP	MAX	MIN	MAX	
			0.8 V		68		70		
			1.2 V ± 0.1 V		128		170		
•			1.5 V ± 0.1 V		189		220		MHz
f _{max}			1.8 V \pm 0.15 V		234		240		IVIITZ
			$2.5~V \pm 0.2~V$		273		250		
			$3.3~V\pm0.3~V$		280		260		
			0.8 V		19.4				
			1.2 V ± 0.1 V	4.4	8.2	16.2	3.4	17.7	
	CLK	Q	1.5 V ± 0.1 V	3.6	5.8	10.7	2.6	11.3	1
t _{pd}	CLK	CLK Q	1.8 V \pm 0.15 V	2.9	4.6	8.4	2.1	3	ns
			2.5 V ± 0.2 V	2.2	3.3	5.9	1.7	6.3	
			3.3 V ± 0.3 V	1.9	2.7	4.7	1.4	4.9	



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Switching Characteristics

over recommended operating free-air temperature range, $C_L = 15 \text{ pF}$ (unless otherwise noted) (see Figure 3 and Figure 4)

PARAMETER	FROM		V _{cc}	T _A = 25°C			T _A = -40°C to 85°C		UNIT
	(INPUT)	(OUTPUT)	,		TYP	MAX	MIN	MAX	
			0.8 V		52		50		
			1.2 V ± 0.1 V		98		130		
•			1.5 V ± 0.1 V		148		180		MHz
f _{max}			1.8 V ± 0.15 V		196		240		IVII
			2.5 V \pm 0.2 V		249		250		
			3.3 V \pm 0.3 V		280		260		
			0.8 V		21.5				
			1.2 V ± 0.1 V	3	9.1	17.4	4.1	19	
	CLK	Q	1.5 V ± 0.1 V	3.2	6.5	11.7	3.2	12.3	
t _{pd}	CLK	Q	1.8 V ± 0.15 V	2.7	4.2	9.2	2.6	9.8	ns
			2.5 V ± 0.2 V	2.2	3.8	6.5	2.1	6.9	
			3.3 V ± 0.3 V	1.9	3.1	5.1	1.8	5.5	

Switching Characteristics

over recommended operating free-air temperature range, $C_L = 30 \text{ pF}$ (unless otherwise noted) (see Figure 3 and Figure 4)

PARAMETER	FROM	TO (OUTPUT)	V _{CC}	T _A = 25°C			T _A = -40°C to 85°C		UNIT
	(INPUT)	(001701)		MIN	TYP	MAX	MIN	MAX	
			0.8 V		32		20		
			1.2 V ± 0.1 V		71		80		
•			1.5 V ± 0.1 V		104		120		MHz
f _{max}			1.8 V ± 0.15 V		133		160		IVIITZ
			$2.5~V\pm0.2~V$		181		220		
			$3.3~V\pm0.3~V$		257		260		
			0.8 V		28.4				
			1.2 V ± 0.1 V	5.1	11.8	20.7	6.2	28.7	
	CLK	Q	1.5 V ± 0.1 V	4.8	8.5	14.1	6.9	16.7	20
t _{pd}	CLK	Q	1.8 V ± 0.15 V	4	6.9	11.2	2	13.3	ns
			2.5 V ± 0.2 V	3.3	5.1	7.9	3.2	9.3	
			3.3 V ± 0.3 V	2.9	4.2	6.4	2.8	7.5	

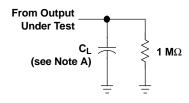
Operating Characteristics

 $T_A = 25^{\circ}C$

	PARAMETER	TEST CONDITIONS	V _{CC}	TYP	UNIT
			0.8 V	2.5	
			1.2 V ± 0.1 V	2.5	
_	Davies dissination conscitous	4 40 MH-	1.5 V ± 0.1 V	2.5	
C_{pd}	Power dissipation capacitance	f = 10 MHz	1.8 V ± 0.15 V	2.5	pF
			2.5 V ± 0.2 V	3	
			3.3 V ± 0.3 V	3	

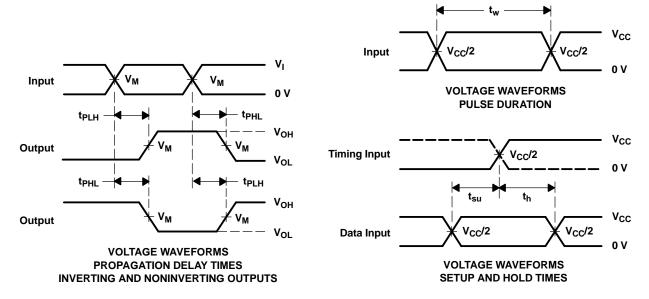


PARAMETER MEASUREMENT INFORMATION (Propagation Delays, Setup and Hold Times, and Pulse Duration)



LOAD CIRCUIT

	V _{CC} = 0.8 V	V _{CC} = 1.2 V ± 0.1 V	V _{CC} = 1.5 V ± 0.1 V	V _{CC} = 1.8 V ± 0.15 V	V_{CC} = 2.5 V \pm 0.2 V	V _{CC} = 3.3 V ± 0.3 V
C _L V _M	5, 10, 15, 30 pF V _{CC} /2 V _{CC}	5, 10, 15, 30 pF V _{CC} /2 V _{CC}	5, 10, 15, 30 pF V _{CC} /2 V _{CC}	5, 10, 15, 30 pF V _{CC} /2 V _{CC}	5, 10, 15, 30 pF V _{CC} /2 V _{CC}	5, 10, 15, 30 pF V _{CC} /2 V _{CC}



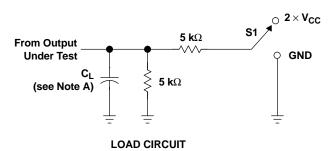
NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $t_r/t_f = 3 \text{ ns}$.
- C. The outputs are measured one at a time, with one transition per measurement.
- D. t_{PLH} and t_{PHL} are the same as t_{pd} .
- E. All parameters and waveforms are not applicable to all devices.

Figure 3. Load Circuit and Voltage Waveforms

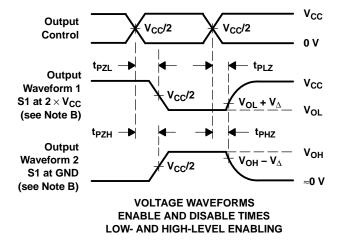
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PARAMETER MEASUREMENT INFORMATION (Enable and Disable Times)



TEST	S1
t _{PLZ} /t _{PZL}	2×V _{CC}
t _{PHZ} /t _{PZH}	GND

	V _{CC} = 0.8 V	V _{CC} = 1.2 V ± 0.1 V	V _{CC} = 1.5 V ± 0.1 V	V _{CC} = 1.8 V ± 0.15 V	V_{CC} = 2.5 V \pm 0.2 V	V _{CC} = 3.3 V ± 0.3 V
CL	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF	5, 10, 15, 30 pF
V M	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2	V _{CC} /2
VI	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}	V _{CC}
V_Δ	0.1 V	0.1 V	0.1 V	0.15 V	0.15 V	0.3 V



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_{O} = 50 \Omega$, $t_{r}/t_{f} = 3$ ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
- F. t_{PZL} and t_{PZH} are the same as t_{en} .
- G. All parameters and waveforms are not applicable to all devices.

Figure 4. Load Circuit and Voltage Waveforms

PACKAGE OPTION ADDENDUM



com 29-May-2007

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
SN74AUP1G80DBVR	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G80DBVRE4	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G80DBVRG4	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G80DBVT	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G80DBVTE4	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G80DBVTG4	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G80DCKR	ACTIVE	SC70	DCK	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G80DCKRE4	ACTIVE	SC70	DCK	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G80DCKRG4	ACTIVE	SC70	DCK	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G80DCKT	ACTIVE	SC70	DCK	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G80DCKTE4	ACTIVE	SC70	DCK	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G80DCKTG4	ACTIVE	SC70	DCK	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74AUP1G80YZPR	ACTIVE	WCSP	YZP	5	3000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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PACKAGE OPTION ADDENDUM

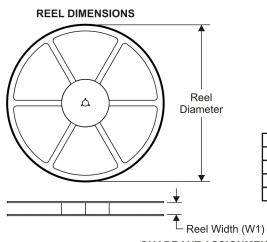
29-May-2007

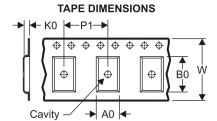
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TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

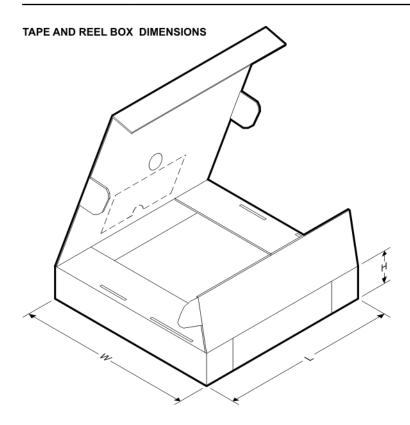
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AUP1G80DBVR	SOT-23	DBV	5	3000	180.0	9.2	3.23	3.17	1.37	4.0	8.0	Q3
SN74AUP1G80DBVT	SOT-23	DBV	5	250	180.0	9.2	3.23	3.17	1.37	4.0	8.0	Q3
SN74AUP1G80DCKR	SC70	DCK	5	3000	180.0	9.2	2.24	2.34	1.22	4.0	8.0	Q3
SN74AUP1G80DCKT	SC70	DCK	5	250	180.0	9.2	2.24	2.34	1.22	4.0	8.0	Q3





*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AUP1G80DBVR	SOT-23	DBV	5	3000	202.0	201.0	28.0
SN74AUP1G80DBVT	SOT-23	DBV	5	250	202.0	201.0	28.0
SN74AUP1G80DCKR	SC70	DCK	5	3000	202.0	201.0	28.0
SN74AUP1G80DCKT	SC70	DCK	5	250	202.0	201.0	28.0

DBV (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
 - D. Falls within JEDEC MO-178 Variation AA.



DCK (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



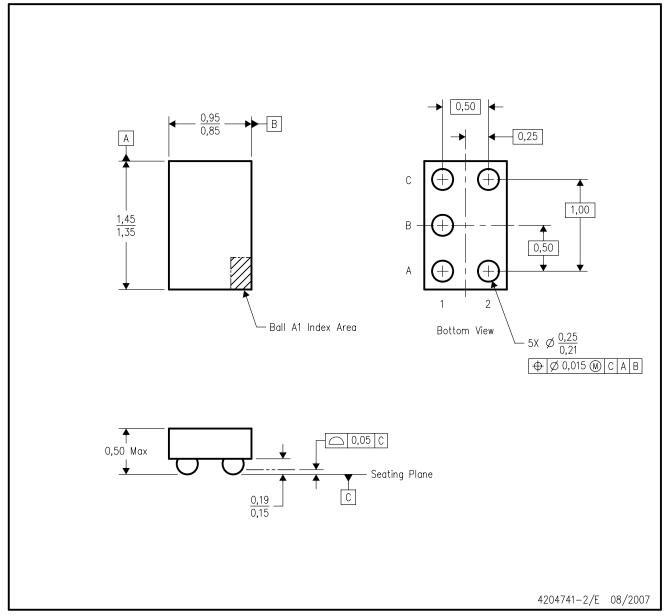
NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-203 variation AA.



YZP (R-XBGA-N5)

DIE-SIZE BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. NanoFree $^{\text{TM}}$ package configuration.
- D. This package is lead-free. Refer to the 5 YEP package (drawing 4204725) for tin-lead (SnPb).

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